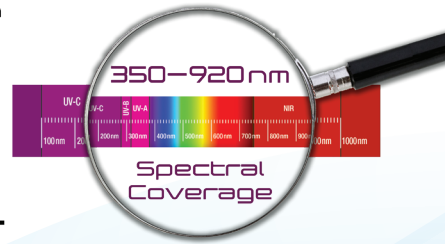
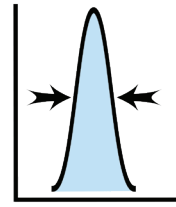


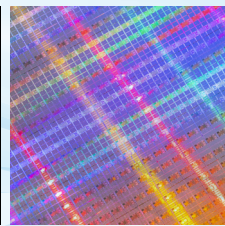
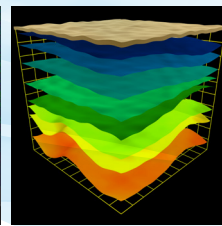
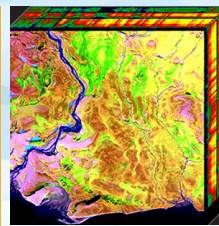
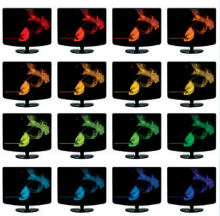
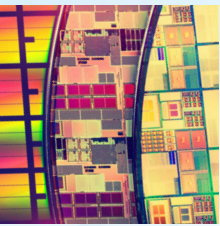
HORIBA

1.3 nm
Resolution



PoliSpectra® 27

Hyperspectral Line Imager



For OEM
Industrial Applications

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Explore the future

PoliSpectra® 27 Spectrometer

Overview

HORIBA has developed a compact industrial spectrometer platform that is factory-configurable for use in a hyperspectral imaging system.

In hyperspectral imaging applications, this system can be used as a line-scanning instrument (push-broom) that collects full spectral data simultaneously across the input slit height.

Variations

- VIS and VIS-NIR spectral ranges
- C-mount, F-mount, and bare slit or custom inputs

Applications

- Hyperspectral Line Imaging
- Inspection and Metrology
- Process Monitoring
- Aerial Reconnaissance
- Agricultural Inspection

Features

**Small, Compact, and
Lightweight Design**

**Designed for Industrial
Volume Manufacturing**

**High Throughput
Combined with
Low Stray Light**

Excellent Peak Symmetry



General Spectrometer Specifications

| Optical Specifications | VIS | VIS-NIR |
|----------------------------------|------------|------------|
| Spectral Range | 350-730 nm | 350-920 nm |
| Spectral Resolution (20 µm slit) | 1.3 nm | |
| Spectral Bands (20 µm slit) | 284 | 425 |
| F/# | 2.3 | |
| Focal Length | 157.7 mm | |
| Grating Dispersion | 51.8 nm/mm | |
| Grating Blaze | 575 nm | |
| Grating Groove Density | 401 g/mm | |
| Max Keystone | <15 µm | |
| Spectral Tilt ¹ | <15 µm | |
| Smile | <15 µm | |
| Spectrometer Magnification | 1:1 | |
| RMS Spot Radius (at 500 nm) | <12 µm | |
| Max Spatial Image Height | 4 mm | |
| Wavelength Accuracy | <0.1 nm | |

| Electronic Specifications | VIS | VIS-NIR |
|----------------------------|---------------------------------------|------------------|
| Sensor Model | IMX 226 | IMX 174 |
| Sensor Type | CMOS | CMOS |
| Digital Resolution | 0.09 nm/px | 0.29 nm/px |
| Pixel Size | 1.85 x 1.85 µm | 5.86 x 5.86 µm |
| Active Pixels ² | 2160 x 4024 | 682 x 1936 |
| Dynamic Range | 65 dB | 71.7 dB |
| Full Well | 10.5 ke- | 30 ke- |
| Frame Rate ² | 35 FPS (8 bit) | 220 FPS (8 bit) |
| | 28.2 FPS (10 bit) | 167 FPS (12 bit) |
| ADC | 8, 10 bits | 8, 10, 12 bits |
| Shutter | Rolling shutter, Global reset shutter | Global shutter |
| Power | USB bus power 5 VDC | |

| Dimensions and Weight ³ | VIS | VIS-NIR |
|------------------------------------|----------------------------------|---------|
| Weight | 1.5 lbs (680 g) | |
| Dimensions (WxDxH) | 2 x 3.5 x 2 in (51 x 90 x 51 mm) | |

¹ Versus a sensor row.

² For the maximum 4 mm image height.

³ Not including a lens.

Spectral Resolution vs. Slit Size

| Slit Width ¹ | 20 µm | 32 µm | 45 µm | 100 µm | 200 µm |
|---|--------|--------|--------|--------|---------|
| Spectral Resolution ² (FWHM) | 1.3 nm | 1.9 nm | 2.6 nm | 5.5 nm | 10.7 nm |
| Spectral Bands ³ (VIS) | 284 | 200 | 146 | 69 | 36 |
| Spectral Bands ³ (VIS-NIR) | 425 | 300 | 219 | 104 | 53 |

¹ Custom slit widths available upon request.

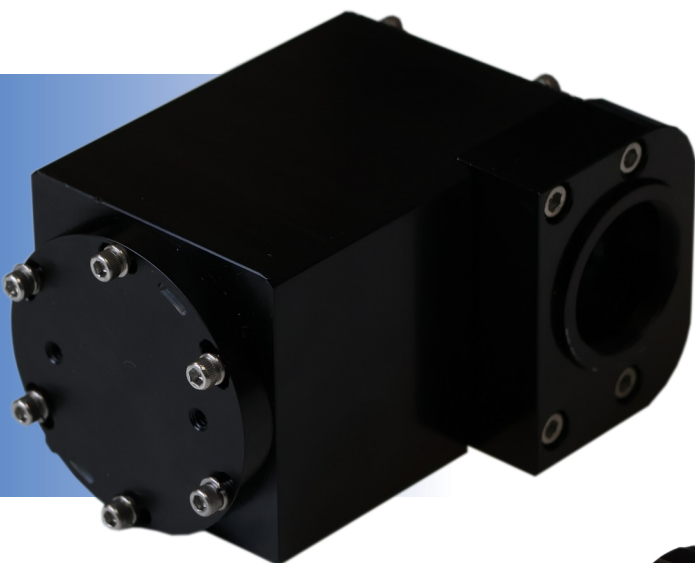
² Max spectral line width (FWHM) for all peaks in the image.

³ The number of spectral bands is the wavelength range/wavelength resolution (FWHM).

PoliSpectra 27 Naming Guide

H27-Sensor-OSF-SLIT-INPUT

Example: H27-226-N-35/4000-C-mount



Slit Size: Width / Height

20/4000
25/4000
35/4000
45/4000
100/4000
200/4000

Camera Options

IMX 174
IMX 226

Input

C-mount
F-mount
Bare Slit
Custom input for OEM quantities

Order Sorting Filter

None: N
OSF: O

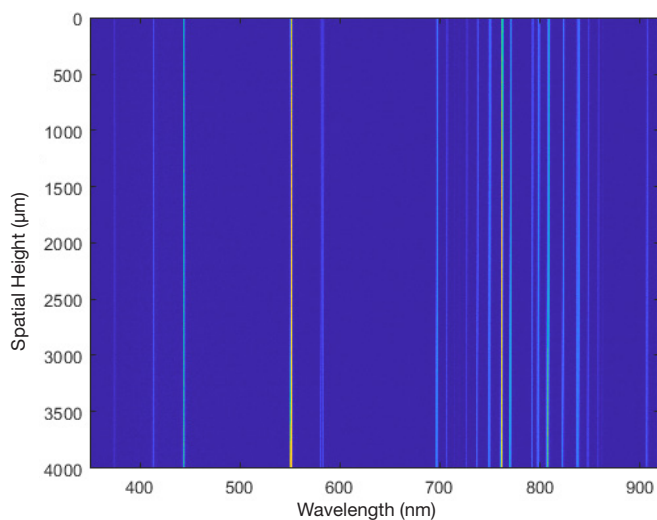


Hyperspectral Imaging Examples

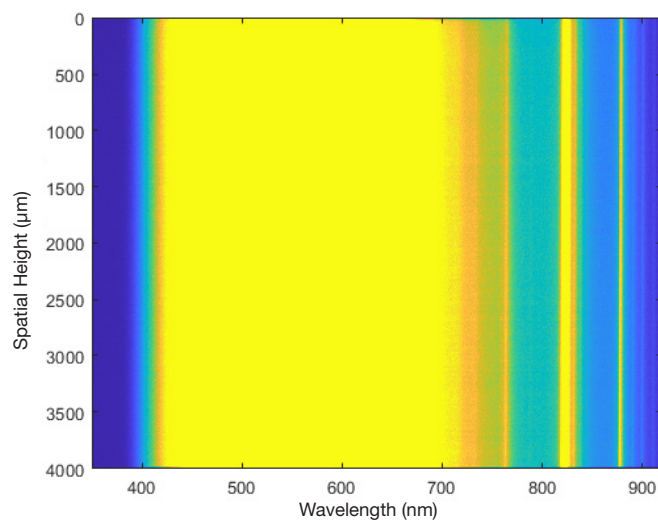
| Field of View | 5 mm | | 300 mm | | 1000 mm | |
|---------------------------------|-------------------------------|-------------|--|------------|---------------------------|-----------|
| Example Targets | Capillaries, Minerals, Plants | | Semiconductor Wafers, Industrial, Food | | Film Thickness, Recycling | |
| Example Lens | VST VS-5026VM | | VST VS-0818VM | | VST VS-0620VM | |
| Focal Length | 50 mm | | 8 mm | | 6 mm | |
| Magnification | 0.8X | | 0.013X | | 0.004X | |
| Image Height | 4 mm | | 4 mm | | 4 mm | |
| Working Distance | 97.5 mm | | 600 mm | | 1500 mm | |
| Spatial Pixels | VIS | VIS-NIR | VIS | VIS-NIR | VIS | VIS-NIR |
| | 2160 | 680 | 2160 | 680 | 2160 | 680 |
| Digital Pixel Scale | 0.002 mm/px | 0.007 mm/px | 0.14 mm/px | 0.44 mm/px | 0.46 mm/px | 1.5 mm/px |
| Spatial Resolution ¹ | 0.016 mm | 0.022 mm | 0.97 mm | 1.3 mm | 3.2 mm | 4.4 mm |

¹ Cross-track spatial resolution, taking into account the point spread function (PSF) of the spectrometer only.

Example of Spectral Images

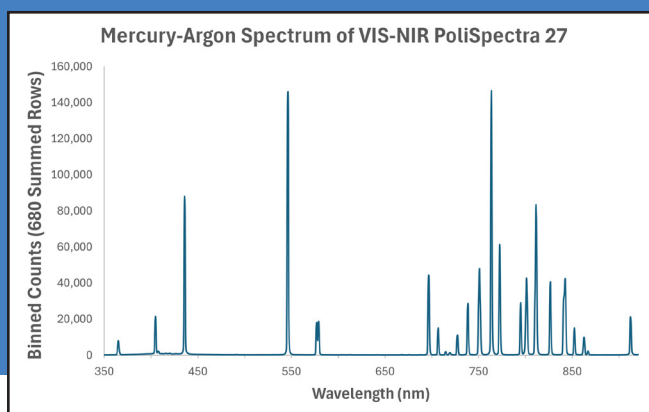


Mercury-Argon Spectrum of VIS-NIR PoliSpectra 27 with Bare Slit

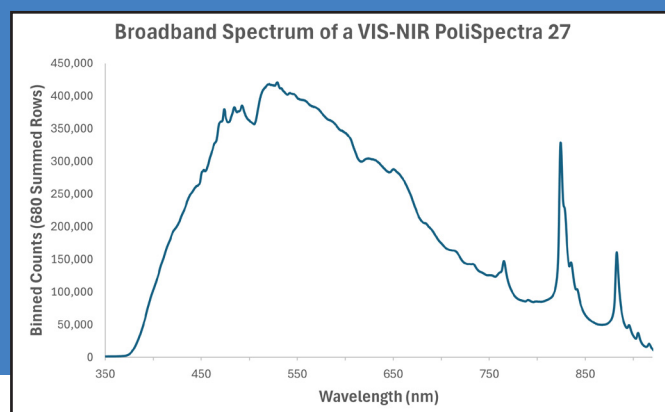


Broadband Spectrum of a VIS-NIR PoliSpectra 27 with VST VS-0818VM Lens

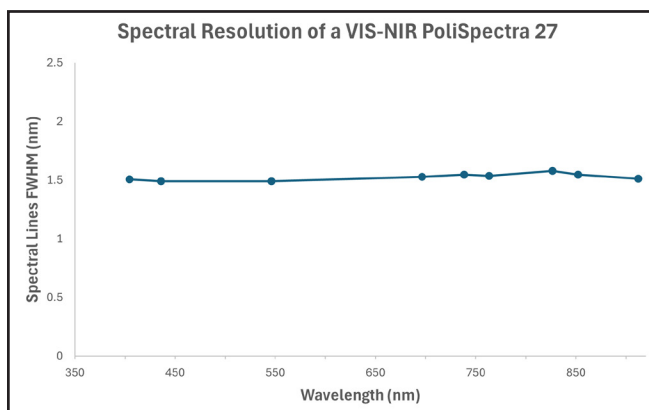
Binned Spectral Examples



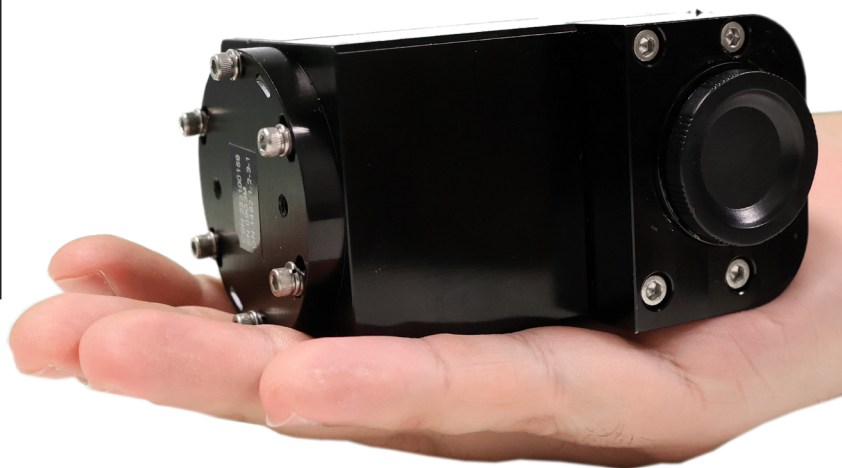
Mercury-Argon Spectrum of VIS-NIR PoliSpectra 27



Broadband Spectrum of a VIS-NIR PoliSpectra 27

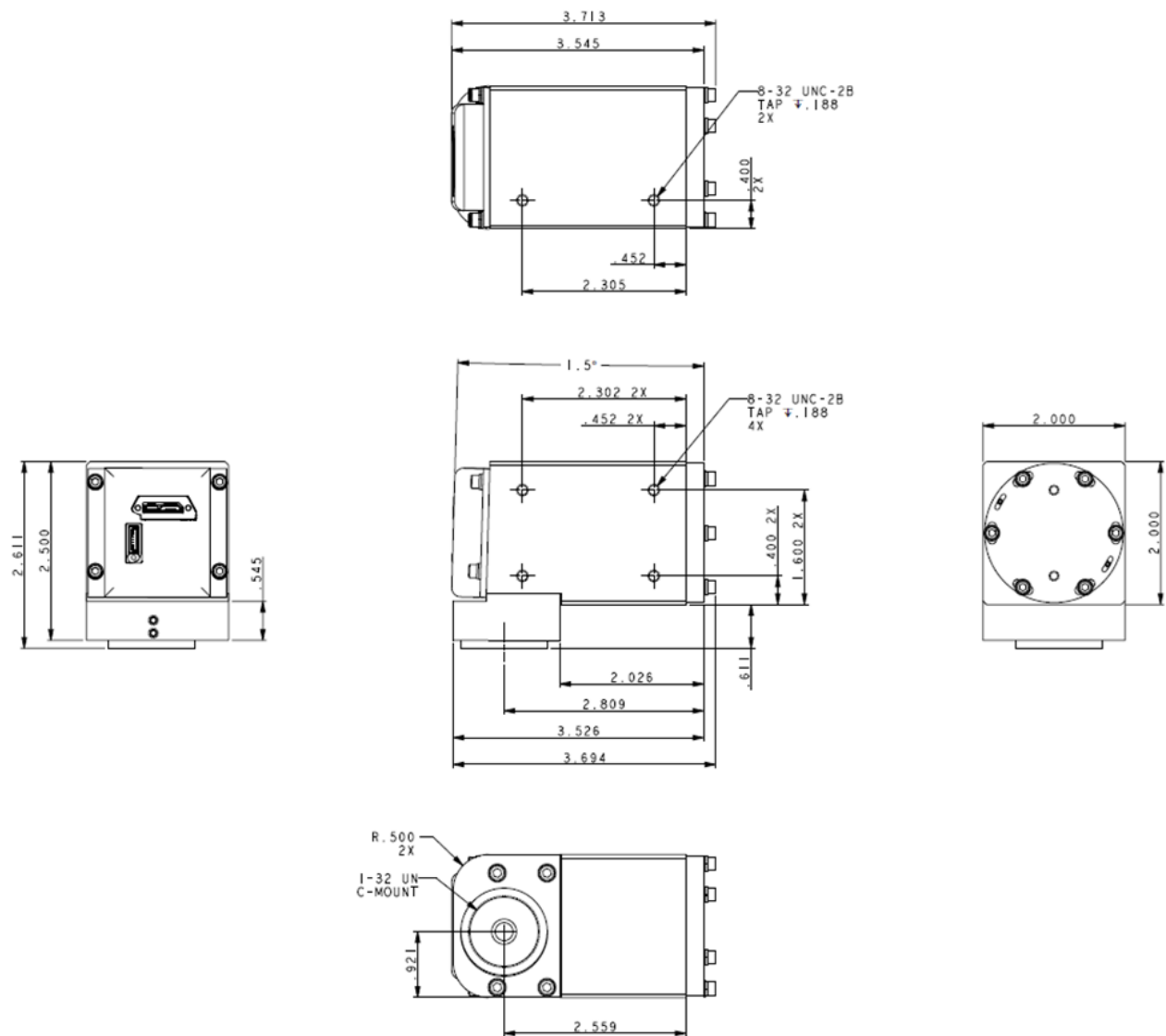


Spectral Resolution of a VIS-NIR PoliSpectra 27



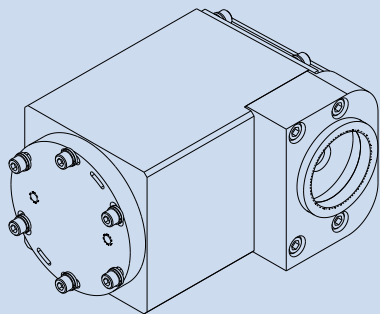
System Mechanical Drawings

VIS and VIS-NIR Variants

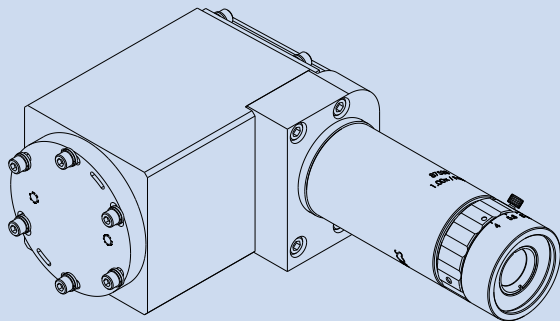


Lens Configurations

VIS and VIS-NIR variants have the same exterior dimensions and connector placement.



C-mount



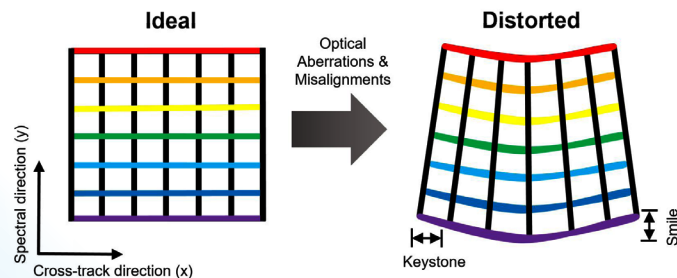
C-mount with Lens

Hyperspectral Imaging Distortions: Keystone and Smile

Definitions:

The **KEYSTONE** property is a band-to-band magnification that changes with wavelength. This involves mixing of spectra from adjacent field positions.

The **SMILE** property is a wavelength shift caused by a change in dispersion with field position [1].



Schematic showing an ideal image compared to a real image with optical distortions [2]

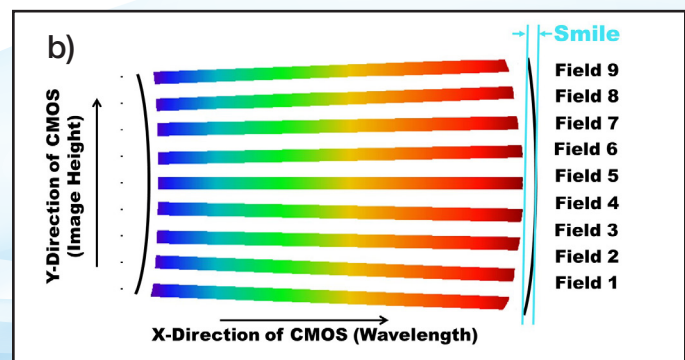
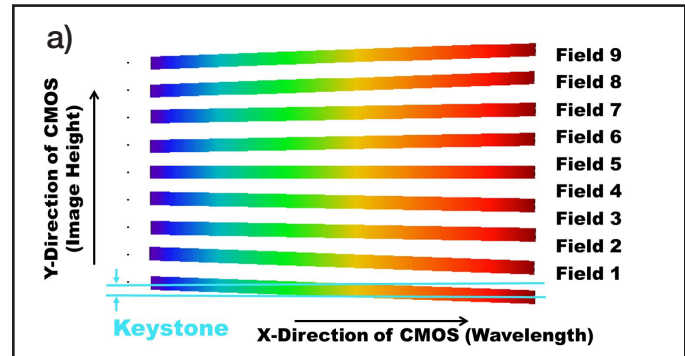
L_{λ} = Pixel center location of each field identifier slit at a given wavelength

$$\text{Keystone} = (L_{\lambda_{\max}} - L_{\lambda_{\min}})$$

C_{λ} = Center pixel location of a given wavelength at each field identifier location

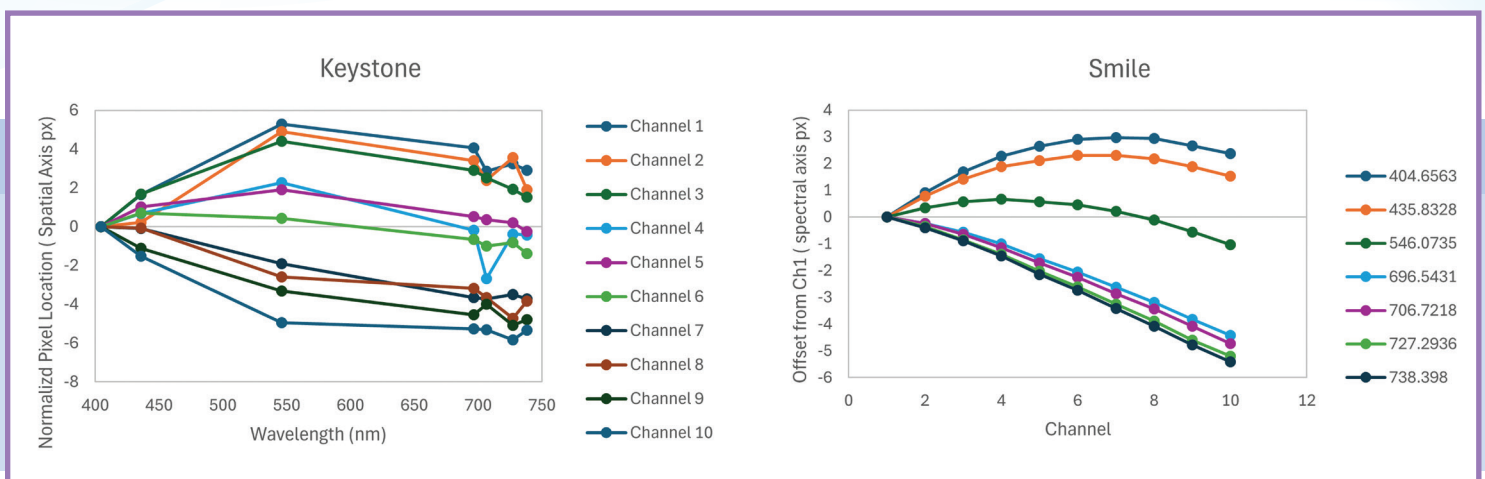
$$\text{Smile} = (C_{\lambda_{\max}} - C_{\lambda_{\min}})$$

KEYSTONE is measured by calculating the maximum displacement a field slit makes as it moves across the entire spectrum, and the **SMILE** is measured by calculating the maximum displacement a wavelength makes as it moves across the entire height of the region of interest.



The method HORIBA uses to measure a) Keystone and b) Smile

Excellent optical performance for PoliSpectra system showing keystone and smile smaller than 15 μm



An example of the production testing for HORIBA's hyperspectral/multichannel spectroscopy systems based on the method described above.

[1] J. Fischer, M. Baumbach, J. Bowles, J. Grossmann, and J. Antoniadis, "Comparison of low-cost hyperspectral sensors," Proc SPIE, Vol. 3438, pp. 23-30, 1998.

[2] N. Yokoya, N. Miyamura, and A. Iwasaki, "Detection and correction of spectral and spatial misregistrations for hyperspectral data using phase correlation method," Applied Optics, vol. 49, no. 24, pp.4568-4575, 2010.

OEM Philosophy and Mission

3 Centers of Excellence Dedicated to OEM Spectroscopy and Camera Solutions in US, EU, and Asia

Our mission is to provide a complete development and manufacturing experience, from optical simulations to opto-mechanical design, and prototyping of spectroscopic and camera systems extending to, and including, electronics, firmware, software design and first articles.

Our products provide superior performance, reliability and stability combined with robust cost reduction. Capable of flexible high volume production capacity in quantities of hundreds to thousands per year, we offer full confidentiality providing "Black Boxes" or private labelling using your logo or graphics.

Unmatched customer service is provided by our exceptionally experienced workforce featuring on-time delivery and flexibility allowing scheduling modifications.

Adhering to Copy Exactly! Processes (CE!), our fully trained staff from engineering to manufacturing form a dedicated OEM engineering force that supports you over the lifetime of the product.

Scientific Segment - OEM Products and Capabilities:

- Custom master optical diffraction gratings
- Diffraction grating replicas (concave, convex and flat)
- Spectrometers, optical assemblies with pre-aligned sensors (CCD, PDA, CMOS, InGaAs) using either customers' or HORIBA's OEM electronics
- OES spectrometers
- Spectroscopy systems or modular engines such as mini fluorometers and mini Raman systems
- Single and double scanning monochromators
- Imaging spectrographs and spectrometers with CCD or CMOS cameras
- Multispectra spectrometers with multiple fiber input / MultiTrack spectroscopy
- Hyperspectral system with HORIBA camera or customer provided (Push-broom configurations)
- Cameras: Spectroscopic deep-cooled scientific cameras (1D and 2D CCD & InGaAS – FI and BI)
- OEM electronics for optosensors ranging from PD and PDA to CCD and CMOS sensors
- Imaging cameras: Uncooled and cooled with FI and BI high-end scientific CMOS
- VUV/FUV spectrometers and CCD vacuum and N2-purged cameras

Scientific Deep Cooled CCD and sCMOS cameras

| Sincerity® | Sylent™ Mini | Sylent™ BLUE | Synapse® EM | VUV Sincerity® |
|---|---|---|--|---|
|  |  |  |  |  |
| Low Cost -50° C Air-cooled OEM Camera | Ultra-compact 4.2 MP Monochrome sCMOS Sensor | TE-cooled to -25° C 4.2 MP sCMOS Sensor | EM CCD Deep-cooled Camera | TE-cooled to -50° C (Vacuum) or -30° C with N2 purge |

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